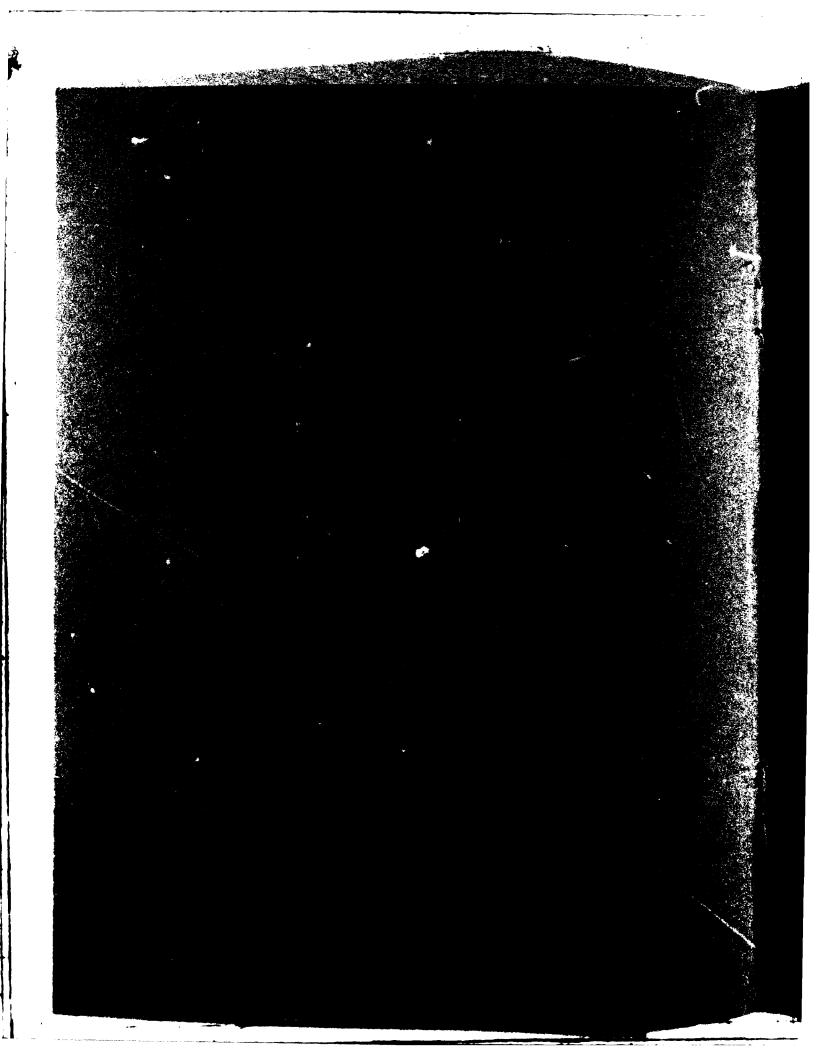


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Meniscograph solderability tests were conducted in-house on an extremely large number of specimens (7000) obtained as contract residue. Parameters evaluated were primary and secondary specimen coatings, thickness of coatings, environments that specimens had been exposed to, temperature of the solder bath, and type of flux. Results quantify the solderability of various coatings, and compare the results of the meniscograph test method with the visual test method.

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PROJECT ENGINEER'S EVALUATION

Mr. Cammarere recommended that meniscograph solderability be determined at an intermediate temperature, somewhere between 230°C and 260°C.* As the accuracy of the meniscograph solder pot temperature control is plus or minus 5°C, and upon review of Mr. Cammarere's report and data, it was decided to run further meniscograph tests at 230°C, 260°C and an intermediate temperature of 245°C.

Therefore, one lot of 30 hot dipped tin-lead coated samples, two lots of gold-plated samples (total - 90 parts) and three lots of tin-plated samples (total - 167 parts) were run at 230°C, 245°C and 260°C. All samples were steam aged for one hour (in accordance with Method 2022 of MIL-STD-883) prior to meniscograph testing. The following is a summary of the results:

1. Hot Dipped Tin-Lead Coating (SnPb):

Thirty samples total, with SnPb coatings of 400 to 700 microinches, all over nickel (Ni) plate, 100 microinches thick, over base metal Kovar. Ten samples were run at each temperature of 260°C, 245°C and 230°C. All samples passed meniscograph solderability test.

- 2. Ninty-nine point 9 (99.9)% Gold Plate (Au):
- a. Sixty samples with 150 microinches of Au over 100 microinches of Ni, over base metal, Kovar. Twenty samples were run at each temperature. All samples passed meniscograph solderability test.
- b. Thirty samples with 50 microinches of Au over 100 microinches of Ni, over base metal, Kovar. Ten samples were run at each temperature. All samples passed meniscograph solderability test.

*Eutectic alloy is Sn 63% - Pb 37%, melting point 183°C. Standard soldering alloy used is Sn 60% - Pb 40%, melting point 191°C.

3. Tin Plate (Sn):

- a. Sixty samples with 300 microinches of Sn over 100 microinches of Ni, over base metal, Kovar. Twenty samples were run at each temperature. All samples passed meniscograph solderability test.
- b. Sixty samples with 100 microinches of Sn over 100 microinches of Ni, over base metal, Kovar. Twenty samples were run at each temperature:

260°C - 12 passed, 8 failed

245°C - 1 passed, 19 failed

230°C ~ 0 passed, 20 failed

c. Forty-seven samples with 200 microinches of Sn over base metal, Kovar (no undercoat). Fifteen samples at 260°C, 16 each at 245°C and 230°C:

260°C - 15 passed, 0 failed

·245°C - 6 passed, 10 failed

230°C - 2 passed, 14 failed

These results confirm Mr. Cammarere's findings and recommendations concerning the temperature of testing. The hot dipped tin-lead coated and the gold plated specimens, all of which met, or were in excess of, the lead finish requirements of MIL-M-38510E, Microcircuits, General Requirements for, passed the meniscograph solderability test at all temperatures. It is obvious that a solderable part will test good at any temperature that is 230°C or above. The tin coating on lot 3a of the tin plated parts was also well in excess of 38510 lead finish requirements, and was also quite solderable at all temperatures. Again, a solderable part will test good at any temperature. The coating on lot 3b tin coated parts did not meet the 38510 thickness requirements, but had an undercoat of nickel. Visually, after steam aging, the parts appeared oxidized prior to the solderability testing. The results at 230°C indicate that these were nonsolderable parts. However, at 260°C, 66% of these nonsolderable parts passed the test. At 245°C only one part out of 20 (5%) passed solderability.

The results of this lot indicate that 260°C is too high a temperature to test nonsolderable parts. Specimens tested at that temperature passed when really they were not solderable. The coating on the final lot of tin specimens, lot 3c just met 38510E lead finish requirements (i.e., minimum 200 microinches thick, no undercoat). Again, visual inspection, after steam aging, showed some oxidation prior to solderability testing. At 260°C, all specimens passed, at 230°C, 12% passed, and at 245°C, 37% passed. These results indicate that these parts are marginal solderability wise, that at 260°C, nonsolderable parts are being passed, at 230°C, possibly the tin coating is not being fused, and that testing at 245°C is an acceptable compromise.

Industry's and our previous experience with the visual test methods of MIL-STD-883 and 202 have lead us to believe that 260°C is higher than necessary, because parts were passing the solderability test, but being rejected at assembly. Also, tin plated parts that tested good at 230°C, were actually non-solderable, and the tin was not fusing during solderability testing. On assembly, the parts failed because of non-solderable surfaces under the tin.

All of these factors have lead us to concur with Mr Cammarere's recommendation to run solderability at an intermediate temperature, and have chosen 245°C as a viable compromise. We have already recommended that Method 2003.2 of MIL-STD-883B and Method 208C of MIL-STD-202E be changed to 245°C. In the case of Method 2022 of MIL-STD-883B, we will propose that 245°C also be used.

Finally, Mr. Cammarere recommended that the pass/fail criteria of Method 2022 (see Para 3.5 of Appendix I) should be changed because of the difficulty in determining the circumference of the part being tested, and other problems associated with quantitatively determining the absolute wetting force.

Thwaites, et al⁽⁷⁾, has demonstrated that the time it takes the meniscograph trace to reach two-thirds its maximum value is actually more indicative of good solderability, rather than an absolute force measurement. This has been confirmed

by R. H. Oehme, G.E. Company, Utica NY. Cassidy and Lin⁽⁸⁾ have also reported that specimens indicating faster meniscograph wetting times were more solderable specimens. Mr. Cammarere's experimental work supports this conclusion. Therefore, we will propose that Para 3.5b of Method 2022 be changed to read:

"That the recorded signal trace reaches two-thirds of its maximum value in 1 second or less of test time."

INTRODUCTION

In modern times, when microcircuits are discussed, most individuals begin to think in terms of very sophisticated, sensitive, and condensed electronic components performing arrays of memory and processing functions. However, although this is all true, if the link between the sophisticated electronics of the microcircuit and the outer world is broken, the reliability of the package and its electronic chip is all but worthless. Since a vast amount of the chips in use are soldered into their circuit positions, and soldering techniques have become quicker and more automated, the importance of the solder connections, or joints, is of prime importance.

Most exterior package leads are made of an iron-nickel-cobalt alloy that has a thermal expansion factor approximately equal to the ceramic of the package. This reduces failures due to thermal stresses under burn-in conditions. The surface of the material, however, is very rough, and solder will not adhere readily to it. It is common to plate a metal such as nickel over the base to smooth it, and then to apply a smooth surface plating of gold or tin over that, since solder adheres most readily to these. The object is to find the best combination of material, thickness, and surface treatment to allow the greatest solderability. Solderability tests, therefore, are of the utmost importance.

Until very recently, the military solderability tests were all visual. Soldered specimens were viewed under a microscope, and depending on the "look" of the finish and the percentage of the metal surface to which the solder did not adhere, a judgment was made as to whether or not the specimen passed or failed. The following visual tests are in use at the present time:

- 1. MIL-STD-202E, Method 208C
- 2. MIL-STD-883B, Method 2003.2
- 3. MIL-STD-750B, Method 2026.3.

These three tests differ slightly in their respective inspection criteria, but they are similar in that they are subjective tests, all depend somewhat upon the inspector, and they all measure the amount of dewetting the sample undergoes.

The meniscograph was developed during the past ten years by General Electric Corporation of England, (1) (2) (3) (4) and gives a quantitative analysis of the wetting that a sample undergoes. In recent years, it was written in as Method 2022 of MIL-STD-883B, (5) (6) and will be studied henceforth. Figure 1 is an illustration of the meniscograph.

PURPOSE

The purpose of this project was to ascertain whether or not the results of meniscograph solderability tests are compatible with results obtained from visual examination. Also, it was to determine if MIL-STD-883B, Method 2022 is accurate and sufficient as is, or if it should be revised. A copy of Method 2022 is included as Appendix I.

THEORY

The meniscograph solderability test works on the principle of wetting. The results depend upon how quickly wetting takes place, and the extent to which it occurs. (It is therefore indirectly related to the wetting Angle 8). Diagram I shows molten solder wetting a metallic surface, and some of the forces involved. Assume that the metal sample in the diagram is actually being run on the meniscograph. If such was the case, the sample would be suspended from a load cell inside the machine. The load cell merely changes force variations to electrical impulse variations according to some linear relationship. Before commencing with the test, the experimenter would have calibrated and adjusted the instrument so that the weight of the sample is equivalent to a zero reading on the instrument's force meter. Hence, the weight of the sample is neglected during the test, and only external forces on the sample are measured. Flux* was applied to all of the samples to clean the *Type R Flux of OQ-S-571

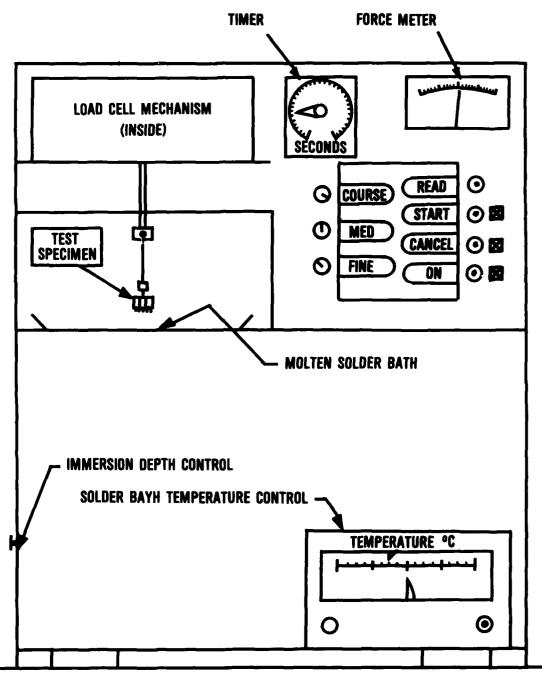
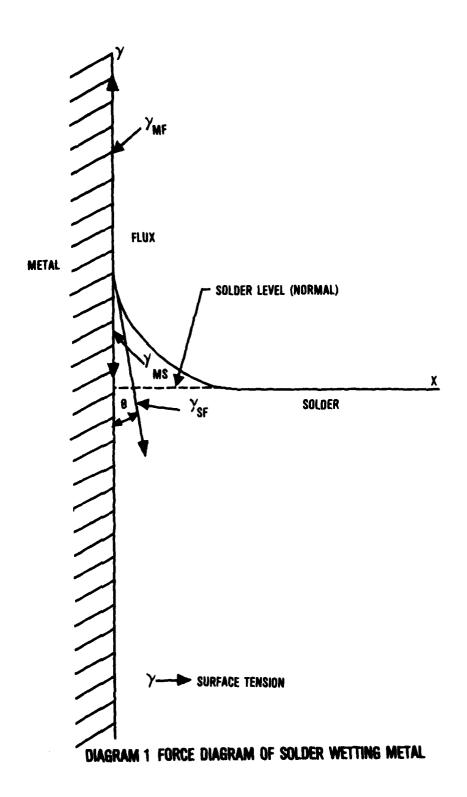


FIGURE 1 MENISCOGRAPH SOLDERABILITY TESTER



surface so that the solder would more readily adhere to it. The object is to get a large Y_{MF} value. It is the Y_{MF} value that pulls the solder up the sides of the specimen. Once the solder rises over the normal solder level, its' weight exerts a downward force on the sample which the meniscograph's force meter picks up via the load cell. As θ approaches zero, Y_{MF} increases, and so a small wetting angle is desired to produce a greater surface tension. This can be shown by the following equation:

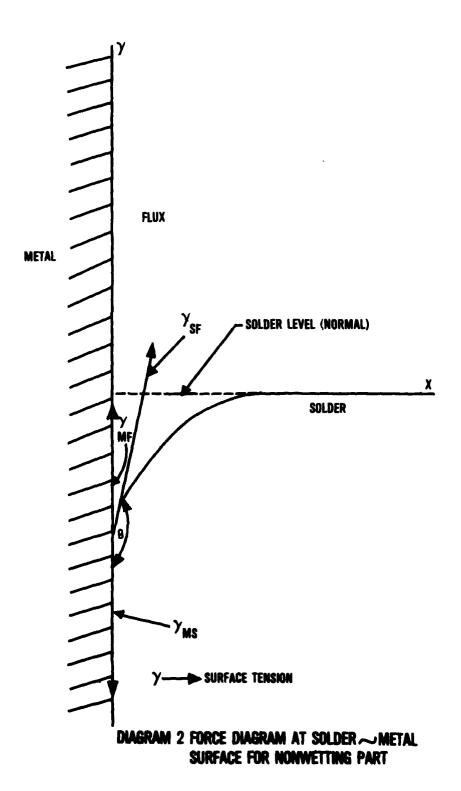
$$Y_{MF} = Y_{MS} + Y_{SF} \cos \theta$$
.

This was obtained by resolving the forces in the Y direction. From this equation, it can be seen that as θ approaches zero, $\cos\theta$ approaches one, and Y_{MF} approaches a maximum value of $Y_{MS} + Y_{SF}$. If the sample is non-wetting, the opposite takes place. The solder is pulled down lower than the normal level (Diagram II), and therefore the weight of the displaced solder gives rise to a buoyant upward force on the metal that the load cell equates to a "negative force" on the force meter.

PROCEDURE

The procedure followed was Method 2022 of MIL-STD-883B, with the only change being that all samples were run at both 230°C and 260°C. The procedure listed below is the procedure that was used when running each individual sample.

- i. The sample was placed in the most suitable holder for that type of sample.
 - 2. A light coating of flux was applied. (See Footnote, Page 8).
 - 3. The sample was suspended from the meniscograph's load cell mechanism.
 - 4. Coarse adjustments to the force meter were made.
- 5. The instrument was placed in the "READ" mode, and final adjustments made.
 - 6. The specimen was dipped in the molten solder bath.
- 7. The specimen was cleaned in methanol and saved for future reference, if necessary.



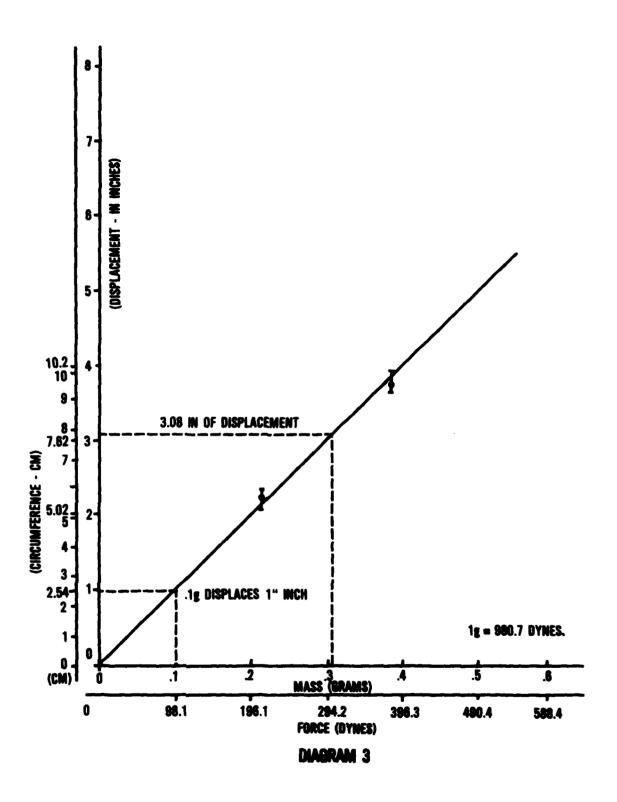
DISCUSSION

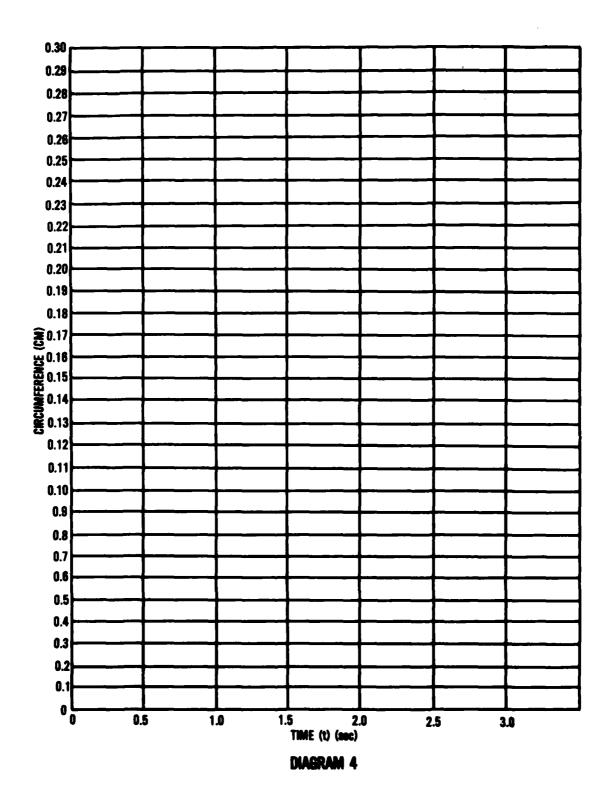
Before the actual experiments were started, it was necessary to determine the relationship between the force exerted on the meniscograph load cell, and the corresponding displacement on the particular X-Y recorder used. This was done by finding the displacements associated with forces of known magnitude. From this, a graph of displacement vs. force was produced, see Diagram III, and from the slope of the determined line, a template was produced, so that a sample of virtually any circumference (or outside perimeter) could be evaluated quickly (see Diagram IV for a copy of the template).

After this was accomplished, the actual tests were run. During the course of these tests, some interesting observations were made. These are noted here, so that in future studies, problems caused by them may be addressed and solved. It was discovered that on like specimens, a heavier coating of flux (see Footnote, Page 8) caused a decrease in the maximum force reached by the specimen. From that point forward, more care was taken to insure a light coating. Also, it was discovered that in two similar samples of unequal circumference, the smaller circumference part seems to have more chance of passing. No actual figures are available due to lack of time; however, that is what preliminary indications would seem to suggest. If this is indeed the case, further investigation should be made to insure a higher degree of accuracy on later tests.

The samples used in these tests were obtained as contract residue from AFML Contract Number F33615-78-C-5084, Manufacturing Technology for Nickel-Boron Plating. RADC is indebted to Mr. Donald Knapke, MLTE/AFML for arranging for the use of these samples. Visual evaluations were made by the contractor personnel and have been reprinted to compare the results of the visual test method at 260°C with meniscograph results at 230°C and 260°C.

Reprinting all of the meniscograph traces is not feasible. Sketches of the





various types of meniscograph traces are included as Figures 2, 3, and 4. One hundred percent represents a wetting force of 300 dynes/cm. Inclusion of the complete tabulation of all the data is also not feasible as it fills some 250 pages. Only a portion of the data is included.

Table 1 reports the percentage of samples passing and failing 80% of the acceptance criteria of Method 2022 at both 230°C and 260°C, and compares these results with the visual results at 260°C only (data on visual results from the AFML report).

Sample types Au 40 through Au 71 were various thicknesses of 99.7 % electroplated gold over various thicknesses of electroless or electrolytic nickel undercoatings. Sample types Au 40A through Au 71A were various thicknesses of 99.9% electroplated gold over various thicknesses of both types of nickel undercoatings.

Tin sample types were various thicknesses of bright acid tin electroplate over various thicknesses of both types of nickel or electroless copper. The tin-lead sample types were hot dipped, all over various thicknesses of both types of nickel undercoatings.

Data on these coatings is contained in Appendix 2, which is a reprinting of Table 22, MIL-M-38510 Component Finishing from the AFML report.

CONCLUSIONS AND RECOMMENDATIONS

Before any attempt is made to come to any conclusions, a few observations and explanations are necessary.

Since the time factor on this project was limited, and the person performing it had but limited experience in this field, this report is more a collection of reduced data (as in depth as was possible), so that individuals with more experience could reach specific conclusions.

On the whole, the evidence received from the 260°C meniscograph tests agreed

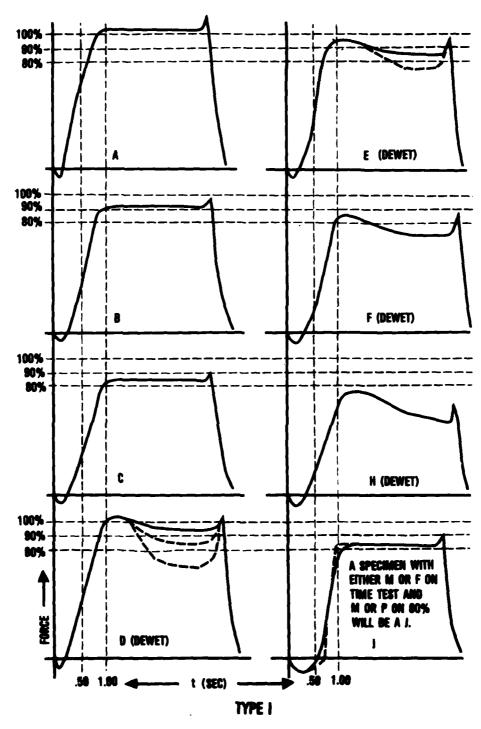


FIGURE 2 MENISCOGRAPH SOLDERABILITY TRACES

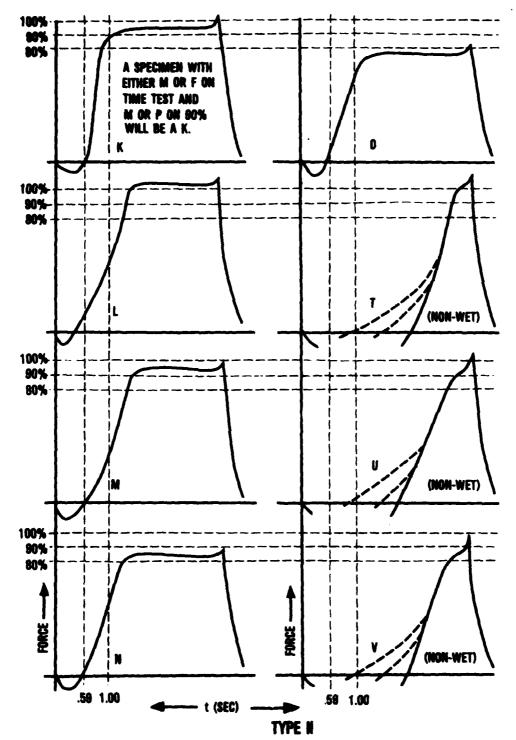


FIGURE 3 MENISCOGRAPH SOLDERABILITY TRACES

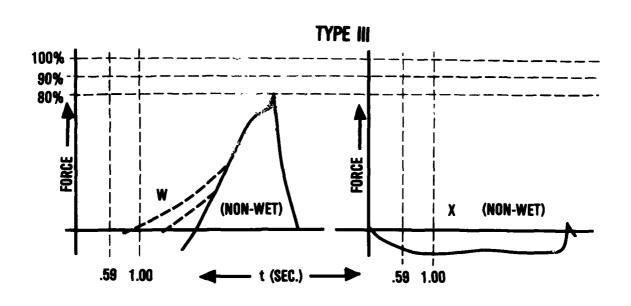


FIGURE 4 MENISCOGRAPH SOLDERABILITY TRACES

TABLE 1 FINAL COMPARISON TABLE $F \ge 240$ Dynes, after Burn-in & Steam aging samples

80% AFTER BURN-IN & AGING

		230°c					
	%P	%F	XM	ZP.	%F	zh	VISUAL
Au 40	33.3%	50.0%	16.7%	83.3%	16.7%	0.0%	Poor, Dewet, . Pinholes
Au 41	83.3%	0.0%	16.7%	100.0%	0.0%	0.0%	Poor, Dewet, Pinholes
Au 42	33.3%	66.7%	0.0%	83.3%	16.7%	0.0%	Poor, Dewet, Pinholes
Au 43	83.3%	0.0%	16.7%	40.0%	60.0%	0.0%	Poor, Dewet, Pinholes
Au 44	66.7%	33.3%	0.0%	66.7%	33.3%	ρ.0%	Poor, Dewet, Pinholes, Non-Wet
Au 45	83.3%	16.7%	0.0%	83.3%	16.7%	0.0%	Poor, Dewet, Pinholes, Non-Wet
Au 46	85.7%	0.0%	14.3%	20.0%	80.0%	0.0%	Poor, Dewet, Pinholes
Au 47	100.0%	0.0%	0.0%	50.0%	50.0%	0.0%	5 Good, 10 Dewet, Non-Wet
Au 48 .	100.0%	0.0%	0.0%	66.7%	33.3%	0.0%	Poor, Dewet, Pinholes
Au 49	14.3%	71.4%	14.3%	50.0%	33.3%	16.7%	Poor, Dewet, Pinholes, Mon-Wet
Au 50	0.0%	100.0%	0.0%	40.0%	60.0%	0.0%	Poor, Dewet, Pinholes, Non-Wet
Au 51	0.0%	100.0%	0.0%	40.0%	60.0%	0.0%	Poor, Dewet, Pinholes, Non-Wet
Au 52	80.0%	0.0%	20.0%	50.0%	50.0%	0.0%	Poor, Dewet, Pinholes, Non-Wet
Au 53	16.7%	50.0%	33.3%	0.0%	83.3%	16.7%	Poor, Dewet, Pinholes, Non-Wet

TABLE 1 (CONTINUED)

80% AFTER BURN-IN & AGING

		230°C 260°C				260°C		
	%Р	%F	%M	%P	%F	XM.	VISUAL	
Au 54	0.0%	83.3%	16.7%	60.0%	40.0%	0.0%	Poor, Dewet, Pinholes, Non-Wet	
Au 55	100.0%	0.0%	0.0%	66.7%	33.3%	0.0%	Poor, Dewet, Rough, Pinholes	
Au 56	16.7%	83.3%	0.0%	0.0%	100.0%	0.0%	Poor, Dewet, Rough, Pinholes, Non-Wet	
Au 57	83.3%	16.7%	0.0%	50.0%	50.0%	0.0%	Poor, Dewet, Rough, Non-Wet	
Au 69	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	Poor, Dewet, Non-Wet	
Au 70	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	Poor, Non-Wet	
Au 71	50.0%	25.0%	25.0%	50.0%	50.0%	0.0%	Poor, Dewet, Rough	
Au 40A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	4 Good, 11 Dewet	
Au 41A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	7 Good, 8 Dewet	
Au 42A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	3 Good, 12 Dewet	
Au 43A	100.0%	0.0%	0.0%				13 Good, 2 Dewet	
Au 44A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	2 Good, 13 Dewet	
Au 45A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	4 Good, 11 Dewet	
Au 46A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	2 Good, 13 Dewet	
Au 47A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	9 Good, 6 Dewet	
Au 48A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	Poor	
Au 49A	50.0%	50.0%	0.0%	100.0%	0.0%	0.0%	14 Good, 1 Dewet	
Au 50A	60.0%	40.0%	0.0%	100.0%	0.0%	0.0%	14 Good, 1 Dewet	
Au 51A	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	15 Good	

TABLE 1 (CONTINUED)

80% AFTER BURN-IN & AGING

		230°C			260°C		
	XP P	%F	XM	ХP	%F	XM.	VISUAL
Au 52A	56.7%	33.3%	0.0%	50.0%	25.0%	25.0%	9 Good, 6 Dewet
Au 53A	100.0%	0.0%	0.0%	75.0%	25.0%	0.0%	Poor
Aŭ 54A	75.0%	25.0%	0.0%	66.7%	33.3%	0.0%	Poor
Au 55A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	9 Good, 6 Dewet
Au 56A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	Poor
Au 57A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	4 Good, 11 Dewet
Au 72A	50.0%	50.0%	0:0%	0.0%	0.0%	100.0%	4 Good, 1 Dewet
Au 73A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	1 Good, 4 Dewet
Au 74A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	4 Good, 1 Dewet
Au 75A	*			100.0%	0.0%	0.0%	2 Good, 3 Dewet
Au 69A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	12 Good, 3 Dewet
Au 70A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	15 Good
Au 71A	100.0%	0.0%	0.0%	100.0%	0.0%	0.0%	12 Good, 3 Dewet
Sn 1	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	3 Good, 12 Poor, Rough, Pinholes
Sn 2	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	11 Good, 2 Pinholes, 2 Dewet
Sn 3	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	9 Good, 3 Pinholes, 3 Dewet
Sn 4	0.0%	100.04	0.0%	0.0%	100.0%	0.0%	Good
Sn 5	0.0%	100.0%	0.0%	33.3%	66.7%	0.0%	Good
Sn 6	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	Good
Sn 7	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good

TABLE 1 (CONTINUED)

80% AFTER BURN-IN & AGING

		230 ⁰ C					
	%P	%F	%M	%P	%F	%M	VISUAL
Sn 8	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 9	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 10	0 0%	100.0%	0.0%	33.3%	33.3%	33.3%	Good
Sn 11	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 12	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 13	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	Good
Sn 14	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	7 Good, 5 Dewet, 3 Pinholes
Sn 15	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	8 Good, 7 Dewet, Pinholes
Sn 16	0.0%	100.0%	0.0%	33.3%	66.7%	0.0%	11 Good, 4 Dewet
Sn 17	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	13 Good, 2 Dewet, Pinholes
Sn 18	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 19	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	4 Good, 11 Dewet
Sn 20	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 21	0.0%	100,0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 22	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	11 Good, 4 Dewet
Sn 23	0.0%	100.0%	0.0%	33.3%	66.7%	0.0%	3 Good, 12 Dewet
Sn 24	0.0%	100.0%	0.0%	1009.0%	0.0%	0.0%	4 Good, 11 Dewet
Sn 25	0.0%	100.0%	0.0%	66.7%	33.3%	0.0%	Good, Pinholes
Sn 26	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 27	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 28	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good

TABLE 1 (CONTINUED)

80% AFTER BURN-IN & AGING

		230°C			260°C		
	%.P	%F	%M	%P	%F	%M	VISUAL
Sn 29	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good, Pinholes
Sn 30	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good, Pinholes
Sn 31	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 32	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
5n 33	0.0%	100.0%	0.0%	16.7%	66.7%	16.7%	Good
Sn 34	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 35	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	13 Good, 2 Pinholes
Sn 36	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 37	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	13 Good, 2 Pinholes
Sn 38	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 39	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good, Some Rough
Sn 76	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 77	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 78	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 79	50.0%	50.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 80	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 2A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	14 Good, 1 Poor, Pinholes
Sn 3A	0.0%	50.0%	50.0%	100.0%	0.0%	0.0%	9 Good, 6 Poor, Rough, Pinholes
Sn 4A	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	Good, Some Pinholes
Sn 6A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	12 Good, 3 Poor, Dewet

TABLE 1 (CONTINUED)

80% AFTER BURN-IN & AGING

		230°C					
	%P	%F	ZM	%P	%F	XM .	VISUAL
Sn 7A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good, Some Pinholes
Sn 9A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good, Some Pinholes
Sn 10A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	13 Good, 2 Poor, Pinholes
Sn IIA	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
\$n 12A	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	Good
Sn 14A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	12 Good, 3 Pinholes
Sn 15A	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	ે કેલ્પના, 12 પરમાર્થ. ક્લા–Wet, Pinholes
Sn 16A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	l3 Good, 2 Dewet, Pinholes
Sn 17A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	ll Good, 2 Dewet, 2 Pinholes
Sn 19A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	2 Good, 13 Dewet, Pinholes
Sn 20A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	12 Good, 3 Dewet, Pinholes
Sn 21A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good
Sn 22A	0.0%	100.0%	0.0%	0.0%	100.0%	0.0%	l Good, 14 Poor, Dewet
Sn 23A	0.0%	100.0%	0.0%	50.0%	50.0%	0.0%	2 Good, 13 Poor, Dewet
Sn 24A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	3 Good, 12 Poor, Dewet

TABLE 1 (CONTINUED)

80% AFTER BURN-IN & AGING

		230°C		260°C			
	ХP	%F	%M	ХP	%F	xM	VISUAL
Sn 25A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	11 Good, 4 Poor, Dewet
Sn 27A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	13 Good, 2 Poor, Pinholes
Sn 28A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good, Some Pinholes
Sn 30A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	Good, Some Pinholes
Sn 31A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	14 Good, 1 Poor, Dewet
Sn 33A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	9 Good, 6 Poor, Dewet
Sn 34A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	13 Good, 2 Poor, Dewet
Sn 37A	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	13 Good, 2 Poor, Pinholes
SnPb 58	0.0%	100.0%	0.0%	100.0%	0.0%	0.0%	12 Good, 3 Dewet
SnPb 59	50.0%	50.0%	0.0%	100.0%	0.0%	0.0%	13 Good, 2 Dewet
SnPb 61			****	100.0%	0.0%	0.0%	Good
SnPb 63	66.7%	33.3%	0.0%	100.0%	0.0%	0.0%	7 Good, 8 Poor, Dewet, Pinholes
SnPb 64	0.0%	100.0%	0.0%	33.3%	66.7%	0.0%	9 Good, 6 Poor, Dewet
SnPb 66	0.0%	66.7%	33.3%	0.0%	100.0%	0.0%	14 Good, 1 Poor, Dewet, Pinholes
SnPb 67	0.0%	100.0%	0.0%	33.3%	33.3%	33.3%	Good
SnPb 88							11 Good, 4 Dewet

with the visual examination results. Dewet phenomena was observed in the gold and in a few tin samples. Some samples also exhibited either total or partial non-wetting characteristics. Also, the tin samples, on the whole, passed well on both the visual, and 260°C meniscograph tests. The differences arise in the 230°C meniscograph tests. The tin samples did not do very well here, but the 99.9% gold-plated samples seemed to deviate little from the 260°C results. Based on these statements, the 260°C meniscograph test and MIL-STD-883B, Method 2003.2 are fairly compatible, but meniscograph tests run at 230°C on tin specimens show big differences.

As to rewriting MIL-STD-883B, Method 2022, a recommendation should be made to include either a 230°C test, or one between 230°C, and 260°C to give more accurate results as to the true solderability of the specimens being tested. Also, thought should be given to lowering the force pass/fail criteria, or changing it, since relatively few of the samples used were able to reach 300 dynes within one second.

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APPENDIX 1

METHOD 2022

MEMISCOGRAPH SOLDERABILITY

l. <u>PURPOSE</u>. The purpose of this test method is to determine the solderability of all ribbon leads up to 0.050 inches (1.27 mm) in width and up to 0.025 inches (0.64 mm) in thickness which are normally joined by a soldering operation and used on microelectronic devices. This determination is made on the basis of the wetting time and wetting force curve produced by the specimen while under test.

These processes will verify that the treatment used in the manufacturing process to facilitate soldering is satisfactory and that it has been applied to the required portion of the part which is designated to accommodate a solder connection.

2. APPARATUS.

- 2.1 <u>Solder meniscus force measuring device (Meniscograph)</u>. A solder meniscus force measuring device (Meniscograph) which includes a temperature-controlled solder pot containing approximately 750 grams of solder shall be used. This apparatus shall be capable of maintaining the solder at the temperature specified in 3.4. The Meniscograph apparatus also includes a strip chart recorder which records the force curve for the device tested.
- 2.2 <u>Dipping device</u>. A mechanical dipping device is incorporated in the Meniscograph, and is preset to produce an immersion and emersion rate as specified in 3.4. The specimen dwell time is operator controlled to the time specified in 3.4.
- 2.3 Container and cover. A nonmetallic container of sufficient size to allow the suspension of the specimens 1-1/2 inches (38.10 mm) above the boiling distilled water shall be used. (A 2,000 ml beaker is one size that has been used satisfactorily for smaller components.) The cover shall be of one or more stainless steel plates and shall be capable of covering approximately 7/8 of the open area of the container so that a more constant temperature may be obtained. A suitable method of suspending the specimens shall be improvised. Perforations or slots in the plates are permitted for this purpose.

2.4 Materials.

- $\frac{Plux}{56}$. The flux shall conform to type with 56, "Flux, Soldering, Liquid (Rosin Base)." The flux shall conform to type RMA or R, as applicable, of MIL-P-14256.
- 2.4.2 <u>Solder</u>. The solder shall conform to type S, composition Sn60, of QQ-S-571. "Solder; Tin Alloy; Lead-Tin Alloy; and Lead Alloy."
- 3. PROCEDURE. The test procedure shall be performed on the number of terminations specified in the applicable procurement document. During handling, care shall be exercised to prevent the surface to be tested from being abraided or contaminated by grease, perspirants, etc. The test procedure shall consist of the following operations:

 - a. Proper preparation of the terminations (see 3.1), if applicable.
 b. Aging of all specimens (see 3.2).
 c. Application of flux and immersion of the terminations into molten solder (see 3.3 and 3.4).
 - d. Examination and evaluation of the recordings upon completion of the solder-dip process (see 3.5).
- 3.1 <u>Preparation of terminations</u>. No wiping, cleaning, scraping, or abrasive cleaning of the terminations shall be performed. Any special preparation of the terminations, such as bending or reorientation prior to the test, shall be specified in the applicable procurement document.
- 3.2 Aging. Prior to the application of the flux and subsequent solder dips, specimens assigned to this test shall be subjected to aging by exposure of the surfaces to be tested to steam in the container specified in 2.3. The specimens Prior to the application of the flux and subsequent solder dips, all shall be suspended so that no portion of the specimen is less than 1-1/2 inches

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(38.10 mm) above the boiling distilled water with the cover specified in 2.3 in place for 60 minutes minimum. Means of suspension shall be a nonmetallic holder. If necessary, additional hot distilled water may be gradually added in small quantities so that the water will continue to boil and the temperature will remain essentially constant.

- 3.3 Application of flux. Flux, type RMA or R, shall be used (see 2.4.1). Terminations shall be immersed in the flux, which is at room ambient temperature, to the minimum depth necessary to cover the surface to be tested. Unless otherwise specified in the applicable procurement document, terminations shall be immersed to 0.16 inch (4 mm) from end of lead. The surface to be tested shall be immersed in the flux for a period of from 5 to 10 seconds.
- 3.4 Solder dip. The dross and burned flux shall be skimmed from the surface of the molten solder specified in 2.4.2. The molten solder shall be maintained at a uniform temperature of $260 \pm 10^{\circ}$ C. The surface of the molten solder shall be skimmed again just prior to immersing the terminations in the solder. The part shall be again just prior to immersing the terminations in the solder. The part shall be attached to a dipping device (see 2.2) and the flux-covered terminations immersed once in the molten solder to the same-depth specified in 3.3. The immersion and emersion rates shall be 1 ±1/4 inch (25.40 ±6.35 mm) per second and the dwell time in the solder bath shall be 5 ±1/2 seconds, unless otherwise specified.
- 3.5 <u>Evaluation of resultant Meniscograph curves from testing of microelectronic</u> de. The criteria fot acceptable solderability during the evaluation of the leads. The cri
 - a. That the recorded signal trace crosses the zero balance point at or before 0.59 seconds of test time.
 b. That the recorded signal trace crosses the positive 300 dynes per
 - centimeter meniscus force point at or before 1 second of test time.
- SUMMARY. The following details must be specified in the applicable procurement document:
 - a. The number of terminations of each part to be tested (see 3).
 - b. Special preparation of the terminations, if applicable (see 3.1).
 - c. Depth of immersion if other than 0.16 inch (4 mm) (see 3.3). đ.
 - Solder dip if other than specified in 3.4. Evaluation of Meniscograph curves if other than specified in 3.5. •.
 - f. Solder composition, flux, and temperature if other than those specified in 2.4 and 3.4.
 - g. Number of cycles, if other than one. Where more than one cycle is appecified to test the resistance of the device to heat as encountered in multiple solderings, the examinations and measurements required shall be made at the end of the first cycle and again at the end of the total number of cycles applied. Failure of the device on any examination and measurement at either the one-cycle or the end-point shall constitute failure to meet this requirement.

APPENDIX 2

					TA	22	MEL-M	1-38510	TABLE 13. MIL-M-38510 COMPONENT FIMSHBIG	3						
Lot Number Identification	Cation	Specified Finish System				Primery Finish	Finish]	Undercont	-		
		7	Thick	Thickness, µis	4	Plating Conditions	ditions		Bath Composition	Thick	Thickness, min	2	Plating Conditions	Millione Millione	-	Bath Composition
			JAY	Range	T (a	(0) (0)	Temp Voltage	ASF		JAV	Pange	a fu	1 (0 (0)	Votage ASF		
ş		Sn (1001/N1/10)	7	55-100 55-100 60-130	~~~	222	 	222	10.0 os/gal Sh 21.8 os/gal BF4 Add: 80 ml	3	****		***	***	- i i i	9.7 ox/gal Ni 2.8 ox/gal H ₃ BO ₄ pH 4.3
=		Sn (100)/N1 (50)	2	60-140 60-115 100-135 106-140		222	000 +++	255		*	\$2\$\$ \$2\$\$	***	***	444		
11		Sn (100)/Al(100)	951	100-175 100-175 123-190 115-145		***	7.00	222		£	\$6-110 \$6-110 \$6-110 \$6-110 \$6-110	•••	222	***		
=	#<=0	Sn (300)/N(110)	2.2	250-300 255-285 270-300 250-285	•••	***		25 25	20.4 oz/gal Sa 20.4 oz/gal BF ₄ Add: 480 ml SnBF ₄	2	20-40 20-40 28-33		***	***		8.5 cs/gs/ Ni 2.4 cs/gs/ H3BO ₄ pH 4.15 Add: 1 liker
=		Sn (300)/N1 (50)	ž	245-326 276-290 255-315 255-300	•••	222	9.5.5	2 2 2		\$0 9	12 - 25 13 - 26 14 - 25 14 - 25	444	222	***		13 6 gm H ₃ BO ₄
21		Sn (300)/NI (100)	8	65-295 100-295 85-275 225-270	•••	222	0.00	222	10.0 og/gal Sn 21.1 og/gal BF ₄ Add: 90 ml TWSR	65	40-85 40-85 65-80	•••	222	2 to 2		8.9 os/gal Ni 3.3 os/gal H ₃ BO ₄ pH 3.7 Add: 1 liter
12	8 < B ∪	Sn (500)/N (10)	2	350-420 350-390 370-400 375-420	222	***	•••	25 25 25		90		8.88	222	***	-	
2	5<00	Sn (500)/NI (50)	÷	400-445 400-445 400-445 405-435	222	35	• • •	255	7.6 oz/gal Sn 18.2 oz/gal BF4 Add: 1.55 litera SnBF4	6	50-85 50-85 55-85	888		8.4.4		8.5 os/gal Ni 2.6 os/gal H3BO ₄ pH 3.7 Add: 2 litera Ni sullamate

TABLE 22. MIL-M-38510 COMPONENT FINISHING (CONTINUED)

3	1	Pariting			5	4	MIL-M	71000-	TABLE 42. MIL-M-20210 COMPONENT FINISHING (CONTINUED)	Z	CONT INCE	à				
1	Identification	Flatch System			_	Primar	Primary Finish						Undercont	ı		
		Primary/Undercont		Thickness, µin	Pla	Plating Conditions	wittons		Bath Composition	Thicks	Thickness, µin	P	Plating Conditions	ndikione		Bath Composition
	-		Avk	Range	Time (min)	(Jo)	Voltage	ASF		Avg	Range	Time (min)	Temp (°C)	Voltage	ASF	
133	21 < B O	Sn (500)/NI (100)	378	385-420 385-406 365-396 355-420	200	222	9.00			11	\$0-110 \$0-75 65-85 70-110		8 8 8	4.60.0		10.5 ox/gai Ni 3.2 ox/gai H3BO4 pH 3.6
124	- < @ U	Sn (100)	2	60-90 60-85 75-90 75-90	ппп	222	0.00						ž		· ·	
325	. < a u	Sn (300)	292	250-340 265-290 250-330 300-340		222	1.0-1.5 1.0-1.5 0.8	2	9.6 oz/gal Sn 19.9 oz/gal BF4 Add: 440 ml SnBF4			***************************************	ž			
125 Report	# < # U	Sn (100)	230	160-295 160-233 205-295 168-238	222	888	0.6.0						ž			
2	2 4 E U	Sn (500)	Uneve	Uneven, spotty plate	#	######################################	0. I. O. II. O. II. O. II. O. II. O. II. O. III. O. II		9.9 oz/gal Sn 18.7 oz/gal BF4			-	Ž	=		
721	Sa Podo A A C B C C	SaPe (200)/Ni (100)	550	315-790	HOT DIP	<u> </u>			ď.	=	106-140 105-130 100-140 105-140	•••	222	444		
22	4 m U	Sa Pb (200)/Ni (150)	4.5	295-856	HOT DIP	<u> </u>			4	3	160-178 146-160 160-175 160-165	•••	222	444		
22	Se Pb62	Sa Pb (2001/NI (200)	670	460-1555	HOT DIP	<u>a</u>			4	13.	100-170 100-145 120-170	222	***	444		10.8 ox/gal N1 3.2 ox/gal H3BOq pH 3.4
051	S < 80 O	Sn (100)/Cu(10)	Ē	155-225 155-210 180-225 170-205	***	222	0	15.7	2.6 oz/gal Sn 23.2 oz/gal BF4 Add: 4.32 tuers SnBF4	Not Detected	itented	9 9 9	222	0 - 4	15.7	10.6 oc/gal Ni 3.0 oc/gal NyBOq pH 3.4 5.8 oc/gal Cu 7.0 oc/gal NyBOq

Beth Composition 4.1 os/gat Cu 6.9 bs/gat H2804 8.0 os/gai Cu 7.1 os/gai H3804 Time Temp Voltage ASF Plating Conditions 9.5.4 ::: ------2 T O ----Undercont ### まさき ままま ### ヹヹヹ まる 둗. ### キャド ... 0.0 0.5 ---999 ---80-125 85-100 100-125 80-05 46-110 56-110 46-45 100-136 110-135 100-130 105-135 30-35 -10, detected 25-40 110-165 135-165 110-140 \$6-60 \$6-60 \$6-50 \$6-50 60-95 60-95 60-80 Pange Thickness, pla (CONTENUED) Detected Ave 3 === 2 = 2 8 ř 5.2 oz/gai Sn 24.8 oz/gai BF4 Bath Composition 4.1 oz/gal Sa 24.9 oz/gal BF4 Ag decrease to 8 ft/nin from 12 ft/min 6.4 os/gal Sn 25 oz/gal BF4 TABLE 22, MIL-M-30510 COMPONENT FINISHING A8F Time Temp Voltage Primary Flaish Plating Cunditions -.00 ~~-------222 444 222 222 222 222 **= =** 9 222 **\$\$\$** 222 222 202 20 222 222 200 290-470 290-370 310-470 345-500 360-500 345-480 390-420 545-850 590-670 613-850 585-775 680-775 585-690 660-770 595-745 595-630 650-745 610-659 140-175 140-165 150-165 130-160 125-190 140-190 140-190 125-190 285-50° 295-395 360-500 265-325 545-585 Thickness, win Pange A ... 3 3 357 637 667 350 651 Primary/Undercont Specified Finish System Sa (1:30)/Cu(100) Sn (500)/Cu (100) Se (300)/Cut 10) Sn (300)/Cu(100) Snt 5001/Cut 10) Sat 5001/Cut 501 Sn (100)/Cu (50) Se (300)/Ca (50) Lot Number Identification ¥ < @ U Sn21 132 33 ž 135 2 131 137 138

•

7.2 os/gal Cu 7.4 os/gal HaBOq 96.6 % Ni act (NiB) pH 7.2 81.5% Ni act 61.2% DMAB act pH 7.17 Add: 246 ml 468A, 516 ml 468B 69 % Ni act pH 6.9 Add: 145 ml 484A, 145 ml 468B Bath Composition Temp Vollage Plating Conditions Undercont 300 70-62 62-63 20-70 00-00 00-05 00-05 61-68 61-61 2 2 2 3 3 3 3 222 223 Time (min) 222 222 222 **\$\$\$** 222 222 165-220 180-230 165-195 185-195 165-265 225 165-265 205-230 245-360 245-360 245-360 Range 40-60 \$0-60 40-45 \$0-56 56-95 75-95 50-55 55-75 30-50 30-50 30-35 40-50 Thickness, µin detected detected Ave Ħ 5 \$ 223 287 2 **8** Š TABLE 22. MIL-M-38510 COMPONENT FINISHING (CONTINUED) Bath Composition 6.2 os/gai Sa 24.8 os/gai BF4 ž ž ž Time Temp Voltage / Primary Finish Plating Conditions • • • 0.-0 9.70 5--988 200 122 2:: 144 20 ם Ħ ξÓ ---... ____ ~~~ 360-1330 160-1660 95-170 95-160 145-170 100-130 295-360 295-360 325-360 300-320 115-150 115-140 120-150 120-150 155-200 175-200 155-175 170-175 55-135 120-136 55-130 75-125 320-670 Thickness, uin Range AVR 8 629 દુ 2 22 178 330 Specified Finish System Primary/Undercost Sn Pb (200)/NIB (100) Sn Pb (200)/NIB (150) Sa Pb (200)/Ni B (200) Sec 100:1/N1B(100) 1300)/NIB(10) Sa (300)/NIB(50) Sn (100)/NtB(10) Sec 1001/N1B(50) Sa Poet A B C Sn Pb65 A B Sa Pod3 A B C Lot Number Identification 8 4 4 5 7 7 7 2 < B U 324 Sn 26 **⋖ ⊞** ひ **∢ #** ∪ ပ 130 3 Ξ 3 3 ፤ £ 3

94.7% Ni act (NIB) ph 6.5 0.75 or/gat Ni (NIP) ph 4.9 Bath Composition 0.68 oz/gal Ni pH 4.7 Add: 20 ml 418A, 20 ml 418C 101.5% Ni act pH 6.0 Time Temp Voltage ASF Plating Conditions Undercost 65 64-63 66-65 77 83.81 80 78 77 77-78 76-78 76-77 80 83-82 82-81 78 9 9 9 9 6 9 200 222 222 222 222 222 222 120-180 165-180 120-160 155-180 105-145 110-125 105-135 130-145 170-225 195-225 170-185 190-220 46-75 55-76 45-65 55-70 30-70 40-70 30-50 40-50 55-65 55-65 50-75 50 25-80 60-80 25-50 60-75 Range Thickness, uln Not detected (CONTINUED) 44 9 Ç ŝ 127 158 195 25 Bath Composition 5.4 oz/gal Sn 24.5 oz/gal BF4 NEW RACKS 5.7 oz/gal Sn 25.2 oz/gal BF4 TABLE 22. MIL-M-30510 COMPONENT FINISHING ž ž ž Time Temp Voltage ASF Primary Finish Plating Conditions 0 - 0 ---==== 0.0.4 **0** - 0 977 === === === 444 집 HOT DIP 245-1050 HOT DIP ξŒ 2 2 2 222 222 ---675-1100 675-840 752-1100 720-930 420-630 450-630 420-500 500-550 300-1325 300-355 300-325 300-330 330-355 500-970 500-970 500-654 725 70-140 70-125 110-140 90-120 135-748 Thickness, win Range Ave 670 \$ 8 631 503 458 110 53 Sn Pb (2001/NI P (200) Sn Pb (200)/Ni P (150) Primary/Undercoat Sn Pb (200)/Ni P (100) Specified Finish System Sn (500)/NIB(100) Sa (300)/NIB(100) Sa (500)/NIB(10) Sn (100)/N(P(10) Sn (500)/NIB(50) Sa Po68 A B Sh Pb67 A B C 98 P566 A 80 O Lot Number Identification Sa 28 A 80 Sm29 **8 4** ≅ ∪ S 4 8 0 8 4 8 C **4 B** O 11 = 149 25 151 152 3 3

0.63 oc/gai Ni(NiP) pH 4.7 Bath Composition 0.70 os/gal Ni pH 4.65 0.72 oz/gal Ni pH 4.65 Time Temp Voltage Plating Conditions **Undercont** 79 80-79 80-79 70 00-70 70-78 77-76 77-76 78-77 62-81 70 92 92 300 222 222 -00 222 222 *** 222 90-120 95-105 80-110 100-120 75-120 100-120 75-105 100-105 96-116 96-105 56-95 96-115 Thickness, µin Range 30-60 40-60 30-50 45-50 20-60 20-60 20-50 45-50 46-63 46-90 60-63 60-63 5-50 25-40 5-50 30-45 50-70 50-65 60-70 60-65 Ave \$ 25 2 \$ 3 8 33 3 TABLE 22, MIL-M-38510 COMPONENT FINISHING (CONTINUED) 4.5 oz/gal 8n 23.7 oz/gal BF₄ Add: 300 mi Sn BF₄ Bath Composition 5.3 oz/gal Sn 24 oz/gal BF₄ Add: 420 ml HBF₄ Time Temp Voltage ASF Primary Flaish Plating Conditions 0.0 0.1.0 0.00 0.10 0.00 **9**0.0 0.0 0.-0 444 444 **###** ### 444 224 44+ === 200 ---222 222 222 100-215 100-215 125-160 140-170 145-450 145-450 170-245 190-450 250-415 250-310 255-290 390-415 275-420 276-316 380-420 290-325 305-470 315-340 385-470 305-345 430-600 430-500 630-600 430-455 450-750 450-500 470-550 600-750 400-795 400-500 670-795 415-460 Range Thickness, µin Ave 145 245 330 335 8 365 Š 565 Primary/Undercoat Specified Finish System Sn (100)/NIP(100) Sn (500)/NIP(100) Sn (300)/NIP(100) Sn (300)/NIP(10) Sn (300)/NIP(50) Sn (100)/NIP(50) Sn (500)/NIP(10) Sn (500)/NIP (50) Lot Number Identification Sm35 Sn33 gn 36 9.38 Sn 37 555 155 2 20 59 36 5 162 157

9.3 oz/gal Ni (Bulhmatel 3.6 oz/gal H3BO4 pH 3.2 Add: 910 ml Ni Bulismate, 130 gm H3BO4 9.4 os/gal Ni 3.0 os/gal h9BO4 pH 2.9 Add: 780 ml Ni Sulfamate; pH adj 4.16 w/ NICO3 Bath Composition Time Temp Voltage Plating Conditions 400 9.00 Unde room ž ž ž 858 222 ### 222 2 2 2 ••• 222 66-116 66-100 66-90 60-115 104-190 106-135 130-190 120-135 65-120 65-115 70-100 65-120 Pre Thickness, µin 40-70 45-70 45-70 40-45 AVE ç 8 2 8 2 (CONTINUED) 5.3 os/gnl Sn 26.5 os/gnl BF₄ Au-pH 4.23 Baumé-150 1.06 os/gnl Au Bath Composition 0.01 oz/gzl Au pH 4.2 Baum6-14º Add: 30 gm K AuCN (20 gm Au) 0. M 04/gal Au TABLE 22. MIL-M-34510 COMPONENT FINISHING Time Temp Voltage ASF 222 222 222 222 222 222 222 222 Primary Finish Plating Conditions 8.00 999 ----2 5 5 #66 222 222 *** 222 222 222 222 100-130 100-120 100-130 110-115 145-200 145-185 150-200 150-170 70-190 70-190 95-110 75-100 75-130 75-100 80-130 90-105 40-106 60-106 40-90 55-75 25-65 25-55 50-65 45-60 40-65 40-65 40-60 45-65 Fig 40-75 40-80 45-75 40-55 Thickness, ula AVE 8 9 116 130 2 80 £ 8 Primary/Undercont Specified Finish System Au(125)/N1(100) Au(50)/N1(100) Au(125)/N1(50) Au(50)/N1(150) Au(50)/Ni(50) Au(125) Au(125) Au(50) Lot Number Mentification **4** 4 **a** 0 4 E C 24 W C A & O A B O Aut Au71 < **₽** ∪ 9 3 16 170 3 3 3 167

TABLE 22. MIL-M-38510 COMPONENT FINISHING (CONTINUED)

-	Bath Composition				10.5 os/gal Ni 3.1 os/gal H ₃ BO ₄ 96.6% Niact (NIB) pp. 6.35	45 mli 4688				97.0% Ni act pH 6.2s Add: 40 mi 468A, 40 mi 468B
	Bath Co	 			10.5 or/get Ni 3.1 or/get H ₃ 1 96.6 % Ninct (pH 6.35	45 ml				97.0% Ni act pH 6.35 Add: 40 mi 468B 40 mi 468B
		ASF				-				
rcont	ondition	Temp Vollage	3.0	40.	4.00	40.E				
Undercoal	Plating Conditions		38	2 2 2	2000	8 6 6	66-69 66-67 66-67	66-67 64 65	64 -67 66 69	70 66-68 68
ļ		Time (min)	222	000	440	222	222	222	222	222
,	Thickness, µin	Phoge	90-210 105-210 90-130 130-200	35-65 45-65 45-65 45-50	75-170 75-170 85-160 100-125	135-185 150-160 155-195 135-160	30-50 40-50 30-50 45-50	35-75 60-75 35-60 45-75	\$0-100 \$0-40 \$0-100 \$0-80	25-60 40-60 25-40 50
	Thick	Ave	155	8	2	8	ž.	9	5	\$
	Bath Composition		Add: 30 gm K AuCN (20 gm Au) Baumé-130	pff 4.3 ph adj to 4.05	0.92 oz/gai Au 890 mg/l CO	Add: 43 gm K AuCN '29 gm Au' pH 3.5 ad)	10 4.0 Baumé 13.50			0.96 oz/gal Au pH 4.18 adj to 4.02 Baumé-13.70
-		ASF	222	222	222	222	222	222	222	222
Primary Finish	Plating Conditions	Voltage	3.5	4 4 6 6	6 4 E 8 O E	6.6.4.	6 6 6 6 6 6	6.00 8.00 8.00	2.00 2.00 2.00 2.00 2.00 2.00 2.00 2.00	
Prima	Nating C	Temp (OC)	888	222	222	33 33	222	222	2 4 4	3 2 2
	_	2 3					(,,,,,,,			
		Time (min)		===	===	222	000	666	n++	•••
	ness, µth	Range Tin	60-160 60-100 105-160 80-90	165-225 150-190 160-225 10 105-140	135-245 135-200 180-245 145-185 18			·		
	Thickness, µin					222	000		n + +	•••
Specified Finish System	Primary/Undercoat Thickness, µin	Range	60-160 60-100 105-160 80-90	105-225 150-190 160-225 105-140	135-245 135-200 180-245 145-185	150-230 16 150-180 16 200-230 18 150-175 18	20-70 20-50 35-70 35	45-70 45-70 50-65 45	45-90 55-60 55-95 4 4 4	50-125 70-100 85-125 50-90
Lot Number Specified Mentification Finish System	Thicknes	Range	95 60-160 60-100 105-160 80-90	170 105-225 150-190 160-225 105-140	180. 135-245 135-200 180-245 145-185	190 150-230 16 200-230 16 150-175 16	50 20-70 3 25-70 3 50 50 3	55 45-70 3 45-70 3 50-65 3	65 50-60 3 45-95 55-60 4	90 50-125 70-100 6 55-125 6 50-90

50.4% DMAB Act PH 7.0 Add: 120 ml 468A, 550 ml 468B 80.3% Ni act 40.5% DMAB act pH 6.3 Add: 155 mt 468A, Adj pH to 7.1 adj pH to 7.1 Bath Composition 96.4 Ni act 34.3 DMAB act pH 7.0 Time Temp Voltage ASF Plating Conditions Undercont 67 -68 67 -68 24-6 6-6 66 64 -63 99-99 68-66 66 66-65 66-65 63-64 65-66 66-65 222 ž 222 222 222 222 222 155-240 200-240 190-225 155-215 125-160 135-160 125-155 125-160 75-120 75-120 85-100 75-130 90-130 95-120 90-100 65-100 135-185 185-105 155-105 135-175 Pange Thickness, pla TABLE 12. MIL-M-30510 COMPONENT FINISHING (CONTINUED) AVE 3 8 8 165 20 45 Add: 28 gm K AucNi19 K AucNi19 Kn Aul 0.99 or/gal Au p H 4.01 (before 4 after add) Bauné: 13.50 before 4 after add. Add: 23.5 gm K AucNi15.9 Dath Composition 0.93 oz/gai Au 920 mg/l CU pH -Baumé -5.4 oz/gal Sn 27.4 oz/gal BF4 222 222 222 222 222 222 202 Time Temp Voltage Plating Conditions Primary Finish - 0.0 0.0.4 222 225 414 222 223 777 222 N I I I - • 5 222 222 55-125 90-120 55-125 00-85 60-140 60-85 110-140 195-290 200-290 195-235 200-245 195-250 195-215 200-250 200-225 200-250 200-225 215-250 210-230 235-300 265-285 240-300 235-260 204-365 221-365 275-340 204-241 Thickness, uis Range AVR £ 8 225 215 220 270 278 Primery/Undercont Au(225)/NIB(150) Aut 1251/NiB(100) Aut 1251/NIB(150) Au(225)/NIB(100) Specified Finish System Sn (300)/NiB(100) Au(225)/NIB(50) Sn (300) Lot Number Identification **€** < ■ ∪ **1** 4 8 0 A 655 **V S** O * < @ U Sn27 **∢ @** ∪ 1254 474 178 3 Ξ ã ā

TABLE 22, MIL-M-38510 COMPONENT FINISHING (CONTINUED)

Lot Number Identification	<u>. 5</u>	Specified Finish System			_	Primary Finish	Finish						Undercoat	je.		
		Primary/Undercost	Thickn	Thickness, µin	콥	Plating Conditions	Aditions		Bath Composition	Thick	Thickness, uin	a.	Plating Conditions	nditions		Bath Composition
:	-		Avg	Range	Time (min)	Temp (°C)	Voltage	ASF	1	Y VE	Ranke	Time (inim)	Temp (OC)	Voltage /	ASF	
136A A 1361	⋖	Sn (500)	\$	415-500 426-465 415-500 430-500	822	222	0.0 0.0 .5	25 25 25	4.8 oz/gal Sn 25.9 oz/gal DF4				¥ Z	· .		
138A A881	Partoes A C C	NtB(100)	355	116-612		410 TOH	A Ed		ž	8	90-125 90-110 90-105 95-125	222	65-65			
140A A PE	\$ 4 m U	MB(150)	456	300-750		HOT 019	a DI		ž	130	115-140 125-140 120-135 115-125	222	\$ \$ \$ \$ \$ \$			87.1 & NI Act (NIB) 100% DMAB Act ph 7.0 Add - 170 ml 466A
162 A A 101 C	4	Sa (100)/NIB(10)	2	90-138 90-138 100-128 100-128	200	222	9-0	222		£		n n n	9 9 9 9 9 9 9 9 9			
143A A A 143A	<	Sn (100)/N(B(50)	82	75-120 75-116 90-120 105-120	200	222	7.7.2	222		‡	45-55 45-55 43-50 45-50	222	99-99			
HAA A A S		Sn (1001/N(B(100)	120	70-170 90-140 70-150		222	0	222		2	55-80 70-80 85-80	222	99-99 99-99 09-99			
8625A 1444 A C C C	<	Sn (100)/N(B(100)	120	70-170 90-140 70-150		222	9:::	222		2	85-80 70-80 85-80	222	99 99			
8635 145.A A 10 10	4	Sa. 773:/NIB(10)	3	305-458 305-458 320-458 380-458	222	222	7.7.	000	4.6 oz/gal Sn 25.6 oz/gal BF4	S	10-10 80-70 80-10 01-50	200	67-67			96.4 \$NI ACT (NIB) 100\$ DMAB ACT PH 6.4 Add - 155 md 466A Adj. pH to 7.1
144 M		9a (500)/NIB(10)	553	425-700 550-700 425-585 465-625	222	222		222	Add - 30 ml TWSR	\$	10-60 10-50 10-50 25-55	***	200			

				TABLE 23.	MIL-N	38610	OMPON	ENT FI	LE 22. MIL-M-38618 COMPONENT FINISHING (CONTINUED)							
Let Humber Manification	Let Hember Steelification	Specified System				Primery Pinish	Fish						Undercont	į		
		Primary/Undercont	Thickness	2000. ptn	E	Plating Conditions	Milione		Bath Composition	Thicks	Thickness, uta	1	tine Co	Platine Conditions		Beth Composition
			Jav	9	Time ;	Time Temp	Voltage	ASF		3 AV	†	Time (min)	Temp (OC)		ASF	
į	8.48 A 80 C 80	Se (500)/NiB(100)	019	\$00-740 \$60-600 \$00-740 \$60-615	222	222	44.4	222	4.7 04/pal Sn 25.2 04/pal BF4	235	190-290 225-290 195-230 190-245	222	2 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9			
18	₹ < □ ∪	MP(100)	0 0 1	390-1200	7	HOT DIP	a.		ž	8	85-105 86-95 80-105		19-10 10-10 10-10			0.88 oz/gal Nichip) pH 4.7 Add-17 ml 418A 17 ml 418C
<u> </u>	∀ < ■ ∪	Se (100)/Ni p (10)	8	75-135 75-110 80-120 80-135	222	255	7.7.7	222		2	0-10-10-10-10-10-10-10-10-10-10-10-10-10	0 0 0 0 0 0 0 0 0	222			91.3\$NI ACI (NIB) 1025 DMAB ACI pH 7.3 11.502/gal Ni (Ni Sulfamete)
<u>ş</u>	¥234	Sn (100)/NtP(100)	951	105-230 105-160 110-205 105-230	200	***	7.7.7	222		3	2	444	80-79 79-79			3.3 oz/m1 H3BO4 pH 3.7
1374	8 4 4 A A A A A A A A A A A A A A A A A	Sn (300)/Nip(10)	280	220-355 250-350 240-335 220-355	• • •	200		222		=	10-35 10-10 20-35	5 sec 15 sec	6 5 5			
<u> </u>	A # 0	Sn (500)/NiP(10)	3	380-940 380-940 440-650 575-615	555	888	0.0	222	5.0 os/gal So 23.7 oz/gal BF	2	20-55 10-55 10-30 10-25	15 sec 10 sec 10 sec	5 6 5			
8	Sa Pb62A A B C	NI (200)	•	230-570		HOT DIP	<u>a</u>		5.0 02/gal Sn 23.7 02/gal BF4	175	115-225 115-105 196-225 140-167	222	222	0.4.4		
\$	% 4 € €	Sn (100)/N1 (10)	8	70-115 75-115 80-105 70-110		222	6.9 1.9	20 00 20 00		\$2	10-35 10-35 20-30	15 sec 15 sec 15 sec	***	4.0		

T FINESHING	
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22 12	
TAREE 22	

				IABLE 48	- 1	21007-1	2 2 2	. NOV	BLE 48. MIL-M-JOSIC COMPONENT FINISHING (CONTINUED)	QED O						
Lot Number Mentification	Lot Number Mentification	Specified Finish System				Prime	Primary Finish	_					Undercont	7		
		Primary/Undercont	Talc	Thickness, µin	Z	ating Co	Plating Conditions		Bath Composition	Thickn	Thickness, µin	2	ating C	Plating Conditions		Bath Compusition
			Avg	Range	Time (min)	Temp (OC)	Vultage	ASF		Avg	Range	Time (min)	Temp (OC)	Voltage ASF	ASF	
A711	A A D	Sn (100)/N1(100)	\$	65-130 85-120 80-130 100-110	000	222	# - 0 - 0	200		001	90-115 96-115 90-105 90-100		344	0.00	222	
\$	وه ح ۸ ه	3a (300)/NI (10)	8	265-340 265-310 265-310	••	**	6.0	22	4.7 os/gal Sn 23.8 os/gal BF4 Add-210 ml	\$	30-40 20-40 30-40	15 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	22	91.	22	0.43 ca/gai Ni (Ni P) pH 4.7 10.6 ca/gai Ni
\$	υ ₹ ∢≌υ	Sa (300)/Ni(100)	98	272-323 280-440 350-440 280-400	• •••			2 222	Sn(BF ₃), L'Titlers HBF ₄	92	36-45 116-140 120-140 115-135	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1			2 222	(NI Editembre) 3.0 oc/gal HyBOq pH 3.6 Add-adj pH to 3.4 w/NiCOg
48	¥018	Sa (500/M(10)	\$	340-504	222	888	0.0.	200	4.7 os/gal Sn 29.5 os/gal BF4 Add-180 mil	9	0 000	2 2 3	998	9.0.6	222	10.3 ox/gal Ni (Ni Bulkamate) 2.9 ox/gal HyBOq pH 3.86
*	. ≦<.a∪	(05) IN/(005) ***	5	340-523 340-148 340-377 340-377	222			222		‡	****			0 0 0		5.5 oz/gal CulCulOg) 6.9 oz/gal Ng 80q Add-280 gm CulOg 23 nd Ng80q
*	4 a u	3r(300)/N(190)	\$	323-453 323-438 340-442 445-483	222	222	9.00	900		2	102-150 102-150 103-150 113-133	lo lo lo	***	***	222	
750	A ITO	(00) 11	\$	360-612	2	=	1.3		7.0	Ĩ	133-235			a .	2	10.5 oz/gal Ni CNi Suddamete)
134	C C C C C C C C C C C C C C C C C C C	C (Share as A) 13 A Sar(100/Cu(10) A C	3	116-256 116-256 116-256 119-176 150-180	22	•• •••	00 700	222 22	Add - i liter TWSR	A	21	3000	ee eee	21.0	11 111	3.4 oz/pzi H3BO4 pH 3.6

TABLE 22, MIL-M-36510 COMPONENT PRIBHING (CONTINUED)

				TABLE	77	- 782	00 e	S S S	TABLE 22. MIL-M-38510 COMPONENT FINISHING (CONTINUED)								
Let Number Scientification	aber cation	Specified Finish System				Prima	Primary Finish	4			i		Undercost	18			
		Primary/Undercont	Thickn	was, uin	ď	ating C	Plating Conditions		Bath Composition	Thicks	Thickness, pin	٦	sting Co	Plating Conditions		Beth Composition	8
			Avg	Pange	Time (min)	Temp (OC)	Voltage	ASF		AVE	Pange	Time (min)	(Oc)	Voltage	ASF		
VICI	A 8 0	Sm(100)/Cu(30)	8	160-230 166-236 150-230 150-170	000	200	4.0.	222		2	40-64 40-64 40-60 40-50	~~~	###	- a a	222		
8 VZE1	\$ 4 60 O	Sn (1001/Cu (100)	175	155-200 155-175 160-200 170-200	000	8.0	-40	2 2 2		2	80-115 85-95 95-115 80-100	***	EEE	#F-9	222		
8 VCC1	< 2 < 2 ∪	Sn (300)/Cu(10)	28	255-340 289-320 265-340 255-279		222	- 6.0	2 2 2		9	10-45 20-40 10-45 10-30	30 sec	# # # # # # # # # # # # # # # # # # #	1.0.1	222		
& V)CI	Se 17 A	Sa (300)/Cu (50)	382	350-435 350-415 385-435 360-425	40.0	333	0.1.	25.2	5.1 oz/gal Sn 31.1 oz/gal BF4	9	45-100 50-100 45-55 50-70	~~~	<u> </u>	000	222	6.0 oz/gal Cu 6.0 oz/gal H ₂ 804	<u>.</u>
8 V 136 8	₹	Sa (500)/Cu(10)	520	270-740 270-455 545-740 500-625	222	222	0.7.7	222		ğ		30 sec 30 sec	EEE	004	222		
137A	SaldA A C	Sn (500)/Cu150)	280	500-675 545-625 500-675 570-605	222	222	0 - 2	25 25		\$	50-90 55-75 50-80 65-90	222	###	-0	222		
29 A361	Sn21A A B C	\$n (500)/Cu (100)	585	500-685 500-590 500-685 565-575	222	3 2 2	1.0	2 2 2 5		8	60-125 60-120 90-125 70-100		FFF		2 S S		

10.2 or/gal Ni 3.5 oz/gal H3BO4 pH 3.4 10.4 oz/gai Ni 3.4 oz/gai H3BO4 pH 3.5 10.4 oz/gai Ni 4.0 oz/gai H3BO4 pH 3.5 Bath Composition 222 222 222 222 222 222 222 222 Temp Voltage Plating Conditions Undercont 999 0 0 0 0 0 0 944 9.00 400 244 222 **\$\$\$** 244 228 222 **\$\$\$** 222 Time (min) ~ ~ ~ ---222 222 100-165 100-145 115-145 115-165 90-120 90-110 100-120 100-115 105-180 105-155 105-155 160-180 130-190 140-160 130-190 130-155 125-180 135-180 125-165 125-145 55-80 65-80 55-75 65-75 Thickness, uln 60-85 60-85 70-80 50-75 50-75 55-65 50-75 Range TABLE 22, MIL-M-38510 COMPONENT FINISHING (CONTINUED) AVR 130 និ 3 2 119 3 15 6 Bath Composition 1.73 oz/gal Au pH 8.8 adj to 10.0 1.68 oz/kal Au pH 8.5 -1 fr. oz of Au replenished -1 tr. oz of Au +20 mi Brightener replenished plf 9.3 adj ~~~ ~ ~ ~ -Primary Finish Time Temp Voltage (min) (OC) Plating Conditions = - = ------2 2 3 2 2 2 2 2 5 222 322 2 2 2 222 222 • *** **0 0 0** 222 222 222 222 222 180-235 180-230 180-230 210-235 135-190 150-190 145-180 135-150 110-140 110-135 115-140 115-140 200-230 200-230 200-220 210-215 120-145 130-145 120-140 120-135 Nange 35-95 35-40 45-60 55-95 30-65 35-55 30-45 50-65 45-75 45-75 50-70 50-60 Thickness, uin Avg 160 55 ç 125 3 132 211 29 Primary/Undercont Specified Finish System Au(225)/Ni(100) A#(125)/N1(150) Au(125)/NIC100 Au(50)/Ni(150) Aut 1251/MH 501 Au(2251/N) (50) Au(50)/NI(100) Aut 501/Ni (50) A B A Autza A 45A A=47A A 4 0 0 Atta CBA Lot Number Identification Audit A A C Aut3A 72 1714 ş 167 **16 1** ¥ 91 173

TABLE 22. MIL-M-18618 COMPONENT FINISHING (CONTINUED)

						-	· -			Į oje	Subject of
		poetitic						Act	10 A 10 A	et Act	_
		Bath Composition						10.2 oc/gal Ni 3.1 oc/gal H ₃ BO ₄ pp 3.9 to 6% Ni Act	M 2 Disk B Ac pH 7.5 330 ml 444A • 106 ml 468B replentabed	83% NI Act 89% DMAB Act ph 7.1 90 ml 4644 B	replenished
		A					*	27.18	1 1 1 1 E	2212	! Ē
-			8				<u> </u>				
Ì	Ĭ	adition.	Voltage								
	Undercont	Philing Conditions		¥	ž	½ —		258	:::	-	223
		Y	Time Temp (min) (OC)		_, _,_,			222	222	222	999
		9	1		-		120-166 120-160 130-170 160-166	86-120 86-120 100-120	106-216 176-216 106-210	186-360 230-360 310-360 185-200	40-90 50-85 40-90 50-80
		Thickness, µin	J.				120-166 120-160 130-170	\$\$\$ \$	106-215 176-215 106-210 100-210		\$3\$\$
E 8		Thick	J AV				150	8	ī	231	8
2		it la						2			-
		Bath Composition	,				1 1 5 E	1.73 oz/gal Au pH 8.5			
		Path C					-1 tr. os of Au + 10 ml brightener replenizhed	1.73 of Hg			
TABLE 22. MIL-M-30610 COMPONENT FINISHING (CONTINUED)		\vdash	8	000						000	999
900	1	tone	Voltage								
۲- ۲-	Primery Finish	S	9-0	333							
77.72	Ž	Plating Conditions	To (0C)	223	322	222	222	222	323	222	222
V PET			ala (ala	***	222	222	222	•••	•••	•••	222
-		4	Bage	5 - 0 5 - 0 5 - 0 5 - 0 5 - 0	30.10	75-230 75-235 80-225 86-230	156-250 156-250 160-200 195-215	######################################	15-76 50-61 50-61	00-00 00-00 00-00 00-00	100-135 100-135 105-130 105-130
		Thickness,	2	****	2325		2222	****	7723	****	
		Ē	Ave	2	<u> </u>	<u> </u>	Ĭ	2	\$	*	13
	.1	100					ĝ	9	<u> </u>	9	ĝ
		7		į	ž	¥		Na Maria	Zelb.	78 P.	N/MB
	-	Primary/Undercont		Au(66) Name	Au(126) Name	Au (225) None	A. (205)/NI (150)	A=(50/N1B(50)	A . (50)/NIB (100)	A4(50)/NIB(150)	Au(125)/NIB(50)
	. 1			£	á	Y « « o	¥ < = 0	¥<=0	8 < 8 0	ALSIA C B A	Austa A B C C
- 1	11			4	440	4 = 0	-	-			
1	Le benter			¥ 5	\$	3	7	Æ	A9F1	177A	7 7

TABLE 22, MIL-M-38510 COMPONENT FINISHING (CONTINUED)

			Į			07.E-3	2000		I ABLE 44. MEL-M-JOSIO COMPONENI PINENINO ICONINDEDI	1100						
Lot Number Identification	i g	Specified Finish System				Prima	Primary Finish						Undercost	rcont		
		Primary/Undercost	Thicke	Thickness, µin	<u>a</u>	Plating Conditions	edilions		Bath Composition	Thick	Thickness, uin	Ř	Plating Conditions	nditions	Г	Bath Composition
			Avg	Range	Time (min)	Temp (°C)	Voltage CD	පි		JAV	Range	Time (min)	Temp Voltage		9	
178A Aus	<	Au(125)/NIB(100)	115	90-130 110-125	Ĩ:	2 2	9.5		u	\$\$	10-100	20	66-70			New NIB Bath
				110-130	2	: 5	•		6.6			2	68-67			96 % DMAB Act
1804 A A B D	Austa A B O	Aut 1253/NIB(150)	£21	115-145 120-130 115-145 130-140	222	222				11	100-138 100-135 100-130 113-120	200	67-66 65-66 66			95.6% Ní Act PH 7.1
1814 A A B	A B O	Au(225)/NIB(50)	झ	136-190 136-190 143-167 150-160	222	000	9.9.9			5	44-65 44-58 44-65 44-65	222	65 64-65			Replenish 16 ml 166A 6 4608
182 A 182 A	A B C	Au (225)/NIB(100)	141	134-197 173-187 154-187 167-180	222	***	•••	000	Regionish -1 tr. os Au + 10 mi brightener	:	76-97 76-95 76-95	000	20.00			pit 1.1 AFTER Au 561 Subject A Bublet A Beginnink A Be
1804 A815	A457A	Au(225)/NIB(100)	٤	150-185 150-185 150-185 165-185	222	333	•••	900		92	135-165 135-155 150-165 140-160	222	222			4 4688 4 4688 BEFORE lot Austa
184 184	VELEV	A#(100/)NIP(50)	2	45-45	2	:	1.5	~	1.65 tr. oz/gal Au, pH 9.1	3	45-90	v	2			6 458B After lot
186A As1	Astan	Au(200/NIP(50)	151	120-170	ė	•	1.0		Replenish -1 tr. or Au	\$	30-70	•	9			97.4% NI Act 96.3% DMAB Act
186 Ast	AsTeh .	Au(100)/NiP(150)	\$	90-100	2	3	1.9	•	brightener	=	100-135	2	3			0.50 or/gal Ni, pH 4.6
NA ANT	AeTsA	Au(2001/NIP(150)	961	65 -170	2	3	1.6	-		125	30-138	2	19-80			38 ml 418A 6 418C
									1.58 tr. oz/gal Au, pH 10.0							0.56 os/gal Ni pH 4.5

TABLE 22, MIL-M-19616 COMPONENT FINIMENG (CONTINUED)

	ĺ													
Let Number	إز	Specified				Selene Cisto	- initial					į	la de re cant	
	Ī	_												
		Primary/Undercont	E E	7	Ē	Paling Conditions	dittons	Bath Composition	Thickness	9	Ž		dittons	This Companies
			Ave	Pange	Time (mile)	Time Temp (min) (OC)	Voltage		Ave	Pange	Time (min)	i G	Yattage	
2	2 < 8 O	Sn (300)/Ni (100)	2222	250-360 250-360 270-310 250-295	•••	\$\$ =	0.0 1.0 25ASF 0.0	5.0 oz/gal de 28.7 oz/gal BF4	2222	\$2.55 \$2.55 \$2.55 \$2.55	•••	225	3.7 3.0 3.0	10.0 m/ml 31 3.3 m/ml HyBO4 pli 4.0
# < # O	F<#U	Sn (300)/NI (100)	2222	200-300 250-300 200-395 230-375	•••	# \$\$	0.00	4.7 oz/gal fa. 30.3 oz/gal BF4	1:25	22.22 22.22 22.23 22.23	•••	522	•••	10.3 on/gal Ni 4.5 on/gal NyBO4 ph 3.0
3	2 × m v	Sn (300)/Ni (100)	#E33	205-595 210-400 205-595 200-350	•••	-::	0.00		2222	3 3 3 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5	•••	222	•••	
4		Sn. 7560 - Sn. 75 (200 min.) B C	#####	180-685 180-455 285-580 250-665	•••	===	0.00		2222	22-23 22-23 22-23 22-23 22-23 23-23	•••	222	••••	
2	- AO	Sn (300)/14(100)	2222	175-350 175-265 190-350 210-260	•••	== \$	1.0 1.1 0.1	4.0 oz/gal Br ₄ 20.0 oz/gal BF ₄	2833	26-175 16-176 16-175 176-175	•••	222	000	10.7 oz/gal Ni 2.6 oz/gal H ₃ BO ₄ pH 3.5
2	€ < a ∪	Sn (300)/N1 (100)	2282	270-346 290-346 270-320 300-330	•••	111		4.7 oz/gal Br 20.7 oz/gal Br ₄	នធិនដ	20 - 20 - 20 - 20 - 20 - 20 - 20 - 20 -	•••	222	•••	10.2 oz/gel Ni 2.7 oz/gel N3BO4 pri 3.0
ž	2 <∞∪	Se (300)/N1 (100)	2222	250-326 240-326 250-300 265-310	•••	## #	0.0.1	1.5 oz/gal Br 30.4 oz/gal BF4	និនិន្ទ	86-120 86-120 86-120 100-120	•••	*	•••	10.3 og/gal Ni 2.9 og/gal H ₂ BO ₄ pri 3.7
*	4 # C	Aut100//01(100)	2233	186-176 140-185 136-176 110-156	222	119	1.6 1.6 1.6 1.6	4.7 co/gal Br 27.4 or/gal Br 1.74Tros/gal Au BDT 11.30 Beumé	1531	126-146 126-146 186-146 186-146	•••	***	•••	10.1 mg/mt Ni 3.4 cm/mt NgBO ₄ pH 2.6
8	P	Au(150/78(1160)	5555	110-170 110-160 115-170 150-170	222	223	4 4 9	pn 10.1 1.077r.oz/pnl Au ph 10.0 (BDT 200)	\$E33	130-300 155-300 130-195 180-170	222	\$5\$	6.6.6.6.6.6.6.6.6.6.6.6.6.6.6.6.6.6.6.	9.3 or/gal Ni 3.5 or/gal H3BOq pH 4.0
8	A 80 O	Press - Sn Pr (200 min) A B C	271 300 300	100-385 225-385 100-320 290-330	222	288	8.1.	1.67Tr.os/gal Au pH 10.0 (BDT 200)	5555	120-275 140-230 120-275 120-160	222	979	6.6.0 6.6.0 6.6.0 6.6.0	9.3 ox/gal Ni 3.5 ox/gal H ₃ BO ₄ pH 4.0

TABLE 23, MIL-M-38510 COMPONENT FINISHING (CONTINUED)

							Auroband	Aurobond		
	Bath Composition		9.4 oz/gal Ni 3.5 nz/gal H ₃ BO ₄ pH 4.0	9.4 oz/mi Ni 3.4 oz/mi H3BO4 pH 4.0		9.2 oc/psi Ni 3.7 oc/psi H3BO4 psi 4.0 Add - 1.17 litere	0.10 Tr.og/gal Au 15º Baumé	9.8 oz/pal Ni 9.8 oz/pal Hg BOQ pal 4.0 0.18 Tr. oz/gal Au g Aurobooz	1.0 oz/pi Ni 1.0 oz/pi H3B04 pi 3.7	10.1 ox/gal Ni 3.8 ox/gal N380 ₄ pii 3.8 0.82 Tr.ox/gal Au 0.82 Tr.ox/gal Au 6.1 w/HCl (Immeraton Bi)
Undercont	tions	Voltage	3.8-3.2 3.8-2.9 3.6-2.9	3.6-2.6 3.6-2.6 3.6-2.6	3.4-2.6 3.6-2.6		3.4 (10ASF		3.6-2.4 6-2.4	
C C	Plating Conditions	Terra Voltage	\$\$\$	\$\$\$	\$\$\$		\$		\$\$\$	111
	L.	Time (min)	222	222	222		_		222	222
	Thickness, µla	Range	140-190 140-190 140-175 140-150	135-260 135-180 190-260 160-190	150-316 160-370 150-315 165-200				135-255 135-255 135-190 175-225	150-265 200-265 170-250 150-175
	Thick	AvR	155 165 155 145	153 220 176	215 227 227 181				F333	122
	Brth Composition		1,73 Tr. oz/pal Au ph 9,7 (BDT 200)	1.59 Tr.oz/(pl Au pH 9.6 (BDT 200)		1.47 Tr.oz/gal Au pH 8.0 adj to 9.8 w/NaOH (BDT 200)		1.5 Tr.oz/gal Au 10 ⁰ Baumé pil 9.8 (BDT 200)	1.4 Tr.oz/gal Au pH 9.7 (BDT 200) 1.74 Tr.oz/gal Au	PR 11.7 11.3 oz/gal Free CN ⁻ (Alautronez 18)
Finish	itions	Voltage	2	7.4.7		***	6.	7.67		
Primary Finish	Plating Conditions	Temp (OC)	\$ 33	282		222	ā	223		
ď	Plate	Time (min)	:::	222		222		222		
	ness, 111n	Range	126-165 120-165 120-140 120-130	115-210 130-170 150-210 115-140	165-500 165-500 215-475 280-375	156-210 175-210 186-180 145-185	75-105 75-105	135-180 150-180 135-175 145-165	205-560 210-560 205-400 220-325	145-340 210-340 145-350 175-300
	Thickness	AVE	8533	8282	3110	5555	22	\$233	****	2222
Specified Finish System	Primary/Undercost		A±(150)/N1(150)	Va(150)/N(150)	Sn Pb (200 min)/ Ni (150)	A=(150)	Au(50)/Aum(20)	A±(150)	Sa Pb (200 min V N1 (350)	Se Pt (200 min V N1 (150)
Lot Number Identification			2 < € C	Aug A B O	3 4 a U	¥<=0	10°4	# < # U	# < # U	# P55
34			Ĩ	ž	§	2	8	<u> </u>	2	§

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TABLE

					•	-		A DELLE AL MIL-M-30310 COMPONENT FINISHING (CONTINUED)						
3	Lot Number	Specified Finish Section				Primery Flater	Figins					Uođe	Úndercont	
_		Primary/Undercost	1 Pic	Thickness, uin]	Plating Conditions	Altions	Bath Composition	Thick	Thickness, µin	1	Plating Conditions	ditions	Bath Composition
		,	Avk	Page	Time (min)	Temp (OC)	Time Temp Voltage		Ava	Range Time	Time (min)	Temp (OC)	Temp Voltage	
3	7 v	Au(501/1 Au(20)	55	95-156 95-155	•	g	9.1				9.	70		
ğ	S A B C	Mireso Safe(200 min.)/ A Nitts0) C C	280 295 341	170-396 170-370 170-385 275-385				1.4 Tr.oz/gal Au ph 9.6 (HDT 200)	8228	120-205 120-175 120-165 165-205	===	\$\$\$	3.6-2.8	10.2 os/gal Ni 4.0 os/gal H3BO4 pH 3.0 0.51 Tr.os/gal Au
50.	A.83	Au(150)	210	175-240	•	左	2.3(6ASF			•				pH 5.3 (immersion III)
3	Sa Post	Sn Pb (200 min V Ni (150)	270	135-560			-		271 173	115-265	2:	2:	3.6-3.6	
	a U		308	240-380				1.74 Tr.02/gai Au	22 23 28	115-170 205-265	22	; ;	3.6-2.6	9.8 oz/gal Ni
								11.3 oz/gal Free CN						pH 4.0

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